

HX710ÿA/Bÿ

24-bit analog/digital (A/D) converter chip with digital temperature measurement output (HX710A)

24-bit analog/digital (A/D) converter chip (HX710B) with measuring (DVDD-AVDD) voltage difference

Introduction

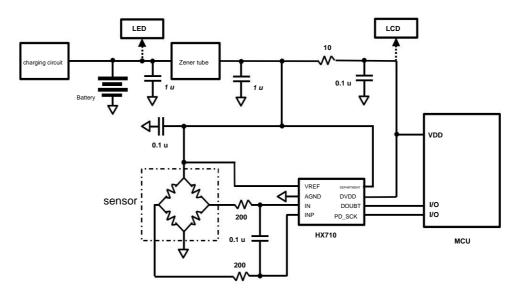
HX710 adopts Haixin technology integrated circuit patented technology, It is a 24-bit A/D converter designed for high-precision electronic scales switch chip. Compared with other chips of the same type, this chip has It has the advantages of high integration, fast response, strong anti-interference, etc. point. Reduce the cost of the whole machine of the electronic scale, improve the efficiency of the whole machine performance and reliability.

The input LNA has a gain of 128, when the reference voltage When the voltage VREF is 5V, the corresponding full scale differential input signal The amplitude is ±20mV. The on-chip clock oscillator does not require any Any external devices. The digital temperature sensor in the HX710A chip can Directly read out the temperature in the chip, that is, in the system. HX710B can Used to detect the voltage difference by detecting (DVDD-AVDD) battery voltage.

All control signals are driven by pins, no on-chip part of the register programming. MCU only needs 2 I/O ports Implements all control of the ADC, including power-down control. Power-on The auto-reset feature simplifies the initialization process at power-on. eatures

On-chip direct temperature measurement and digital output (HX710A) •
(DVDD-AVDD) voltage difference measurement (HX710B) • On-chip
low-noise amplifier with a gain of 128 • On-chip clock oscillator
without any external components • Power-on automatic reset circuit
• Simple digital control and serial
communication: all control is managed
Pin input, on-chip registers do not need to be programmed
• Optional 10Hz and 40Hz output data rate • Synchronously
suppress 50Hz and 60Hz power interference • Power consumption:
Typical operating
current: 1.2mA, power-off current: < 1µA

- Operating voltage range: 2.6 ~ 5.5V
- Operating temperature range: -40 ~ +85°C
- 8-pin SOP-8 or DIP-8 package



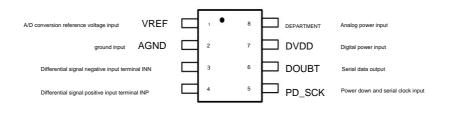
HX710 pricing scale application reference circuit diagram

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Pin description





| Pin number | name perforr | nance | describe |
|------------|-------------------|---------------------------------------|--|
| 1 | VREF Analog | nput A/D conversion reference volta | ge input (1.8VÿAVDD) AGND Ground input Ground input INN Analog input |
| 2 | differential sigr | al negative input INP Analog input o | lifferential |
| 3 | signal positiv | e input PD_SCK Digital input power | off control (active high) and Serial port |
| 4 | clock input D | OUT Digital output serial port data o | utput |
| 5 | | | |
| 6 | | | |
| 7 | DVDD power i | nput digital power input (2.6 ~ 5.5V) | AVDD power input analog power input (2.6 ~ 5.5V), AVDD |
| 8 | voltage should | not be higher than DVDD voltage | |

Table 1 Pin Description



Main Electrical Parameters

| | Conditions and instructions | Min Typ N | /lax Unit | | 0 |
|---|---|-----------|----------------|------------|---------|
| Parameter Full-Scale Differential Input Ra | nge | | | | |
| ÿFSRÿ | V(inp)-V(in) | | ±0.5(VREF/128) | | IN |
| Input Common Mode Voltage Range | | AGND+0.9 | | AVDD-1.3V | |
| VREF input voltage range | | 1.8 | | AVDD V | |
| Noise-free bits (Noise- Vref=Avdo | =5V, Rate=10Hz | | 17 | | Bits |
| Free Bits) | Vref=Avdd=5VÿRate=40Hz | 16 | | | Bits |
| output data rate | | | 10/40 | | Hz |
| output data encoding | two's complement | 800000 | | 7FFFFF HEX | |
| Output Settling Time(2) | | | 400/100 | | ms |
| Non-Linearity Error (INL) Differen | ial Input, Input Zero Drift Compared to | | ±0.001 | | %of FS |
| Full-Scale Gain (Input Offset) | | | 0.01 | | mV |
| Input noise accuracy (Noise Free Resolution) | | | 50 | | nV(rms) |
| Temperature coefficient (Tempera | ture input zero drift (offset drift) | | ±15 | | nV/ÿ |
| Drift) | gain drift | | ±7 | | ppm/ÿ |
| | Temperature measurement range | -40 | | +85 | ÿ |
| temperature sensor (effective bit: | Non-linear error (-40ÿ+85ÿ) Digital | | 0.5 | | ÿ |
| 15 bits) Temperature measuremen | t accuracy (15 bits) | | 20.4 | | LSB/ÿ |
| Input Common Mode Signal Reject | on Ratio At DC, ÿVIN=10mV | | 100 | | dB |
| Power Supply Suppression Ratio | (PSSR) At DC, ÿAVDD=0.1V | | 100 | | dB |
| voltage | AVDDÿDVDD | 2.7 | | 5.5 | IN |
| supply current | normal work | | 1200 | | μA |
| | power outage | | 0.5 | | |

(1) Noise-Free Bits = ln(FSR/Peak-to-Peak Noise)/ln(2).

(2) Output stabilization time refers to the time from power-on, reset or output data rate change to valid stable output data.

Table 2 Main Electrical Parameters



HX710ÿA/B)

analog input

The analog differential input can directly interface with the bridge sensor's differential. The output is connected. Since the signal output by the bridge sensor is small, In order to fully utilize the input dynamic range of the A/D converter, the The input preamp has a large gain of 128. Dang ginseng When the reference voltage VREF is 5V, the full scale corresponding to the gain The differential input voltage is ±20mV.

Power supply

The digital power supply (DVDD) voltage should be the same as the MCU chip power supply voltage. The voltage is the same or not much different to ensure that the serial port data with the MCU. The communication is correct.

The analog power supply (AVDD) voltage should not be higher than the digital power supply (DVDD) voltage. Can use the same number as the MCU chip Power supply, with proper isolation if needed to reduce digital voltage Interference with analog circuits.

The A/D conversion reference voltage input (VREF) should be connected to the sensor's The power supply is connected. This voltage can be taken directly from the analog power supply (AVDD). It can also be divided by AVDD through resistor and sensor supply to reduce sensor power consumption.

clock selection

The clock of the HX710 chip is controlled by the clock oscillator inside the chip Available with a typical output data rate of 10Hz or 40Hz.

Temperature measurement (HX710A)

The digital temperature sensor inside the HX710A chip can directly It is connected to read out the temperature in the chip, that is, in the system. its effective The (stable) number of bits is 15 . Typical temperature measurement accuracy is per Degree (°C) 20.4 readings (15 digits).

When using a digital temperature sensor, attention should be paid to the on-chip Temperature sensor, there is a large zero sum between the chip and the chip gain difference. If used to measure absolute temperature, both zero and gain need To correct. For example, the measured temperature is used to make performance compensation related to the temperature of the system Compensation, zero and gain do not need to be corrected, as long as the line of temperature measuremen Sexuality can meet the requirements.

(DVDD-AVDD) voltage difference measurement (HX710B)

HX710B can be used to measure (DVDD-AVDD) voltage Difference. If DVDD is directly connected to the battery output, and AVDD is provided by the output of the Zener tube, then the HX710B can be used for Direct measurement of battery voltage without any external components.

Serial communication

The serial communication line is composed of pins PD_SCK and DOUT, Used to output data, select output data rate and input signal

When the data output pin DOUT is high level, it indicates The A/D converter is not ready to output data, at this time the serial port The clock input signal PD_SCK should be low. When DOUT goes from high to After the level goes low, PD_SCK should input 25 to 27 different Wait for the clock pulse (Figure 2). where the first clock pulse The rising edge of the output will read the most significant bit of 24-bit data (MSB) until the completion of the 24th clock pulse, the 24-bit input The output data is output bit by bit from the highest bit to the lowest bit. 25th Up to 27 clock pulses are used to select the next A/D conversion

See Table 3 for output data rates and input signals.

| PD_SCK pulse number in | out selection rate | |
|------------------------|-------------------------------------|----------------|
| 25 | Differential signal 10 | Hz temperature |
| 26 | measurement ÿHX710A) | 40 Hz |
| 26 | DVDD-AVDD test Quantity (HX710B) | 40 Hz |
| 27 | Differential signal 40 | Hz |

Table 3 Input Selection and Output Data Rate Selection

The number of input clock pulses of PD_SCK should not be less than 25 or more 27, otherwise it will cause serial communication error.

When the input signal or output data rate of the A/D converter When changing, the A/D converter needs 4 data output cycles to Can be stable. DOUT will go high after 4 data output cycles The level becomes low level, and valid data is output.



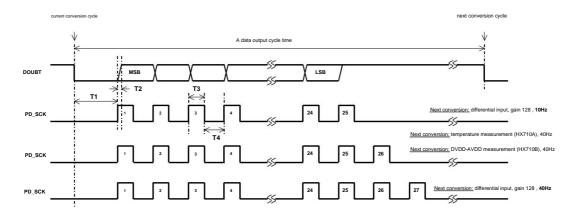


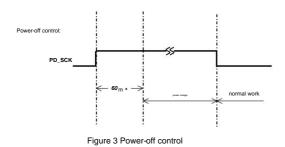
Figure 2 Data output, input channel and gain selection timing diagram

| symbol | illustrate | Min Typ Max | Unit | | |
|--------|---|-------------|------|-----|----|
| T1 | DOUT falling edge to PD_SCK pulse rising edge | 0.1 | | | μs |
| T2 | PD_SCK pulse rising edge to DOUT data valid | | | 0.1 | μs |
| T3 | PD_SCK positive pulse level time | 0.2 | | 50 | μs |
| T4 | PD_SCK negative pulse level time | 0.2 | | | μs |

Reset and power down

When the chip is powered on, the power-on automatic reset circuit in the chip The circuit will reset the chip automatically.

The pin PD_SCK input is used to control the power off of HX710. When PD_SCK is low level, the chip is in normal working state state.



If PD_SCK goes from low to high and stays high level exceeds 60µs, HX710 enters the power-off state (Fig. three). When PD_SCK returns to low level, the chip will Re-enter normal working condition. The chip returns to positive from the power-off state After normal operation, if you want to maintain the conversion rate before power off and input signal selection, the power-down cannot be issued in the number of clock pulses The current data conversion cycle where the change occurs. Instead the clock The next data conversion cycle after the pulse number changes or later.

Chip enters normal working state from reset or power-off state After that, the A/D converter needs 4 data output cycles to stabilize Certainly. DOUT will change from high level after 4 data output cycles Change to low level, output valid data.

Applications

Figure 1 is a typical application of HX710 chip in electronic scale type scheme diagram. This solution uses a Zener tube to simultaneously give the ADC and MCU power supply, it can be used for LED display, also can be used for LCD display.



Reference Driver (Assembly)

| /* | | Called in ASM: can be called in C: extern unsigned long |
|---------------|-------------------|---|
| ReadAD(void); | LCALL ReadAD | |
| | | |
| | | |
| | unsigned long d | lata: |
| | data=ReadAD() | |
| | | ·· |
| | | |
| PUBLIC | ReadAD | */ |
| HX710ROM | segment code | |
| rush | HX710ROM | |
| sbit | ADDO = P1.5; | |
| sbit | ADSK = P0.0; | |
| /* | | R4, R5, R6, R7 R7=>LSB If called in C, R4, |
| | nnot be modified. | x_{1}^{2} , x_{2}^{2} , x_{3}^{2} , x_{4}^{2} , x_{5}^{2} , x_{6}^{2} , x_{7}^{2} , $x_{$ |
| | | dAD: |
| | | |
| CLR | ADSC | //Enable AD (PD_SCK set low) |
| SETB AD | DDO | //51CPU quasi-bidirectional I/0 input enable// |
| JB | ADDO,\$ | judging whether the AD conversion is over, if it is not over, wait or start reading |
| MOV | R4, #24 | |
| ShiftOut: | | |
| SETB AD | DSK | //PD_SCK set high (send pulse) |
| NOP | | |
| CLR | ADSC | //PD_SCK low // |
| MOV | C,ADDO | read data (one bit at a time) // shift |
| XCHON | A,R7 | in data |
| RLC A | | |
| XCHON | A,R7 | |
| XCHON | A,R6 | |
| RLC A | | |
| XCHON | A,R6 | |
| XCHON | A,R5 | |
| RLC A | | |
| XCHON | A,R5 | |
| DJNZ R4 | ,ShiftOut | //Judge whether to move into 24BIT |
| SETB AD | DSK | |
| NOP | | |
| CLR | ADSC | |
| | | |
| RIGHT | | |

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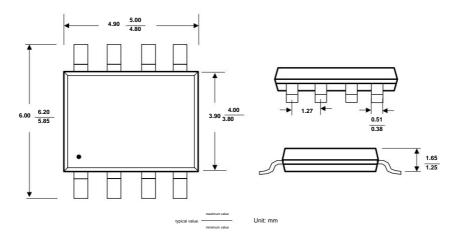
Reference Driver (C) sbit ADDO = P1^5; sbit ADSK = P0^0; unsigned long ReadCount(void){ unsigned long Count; unsigned char i;

ADDO=1; //Non-51 class MCU, omit this line ADSK=0; Count=0; while(ADDO); for (i=0;i<24;i++){ ADSK=1; Count=Count<<1; ADSK=0; if(ADDO) Count++; } ADSK=1;

Count=Count^0x800000; ADSK=0; return(Count); }



package size



SOP-8L package

